

Notice of References Cited	Application/Control No. 10/052,989		Applicant(s)/Patent Under Reexamination HSIEH ET AL.	
	Examiner DAVID VU		Art Unit 2818	Page 1 of 1

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*	B	US-6,348,399	02-2002	Lin, Chun Hung	438/616
*	C	US-5,903,058	05-1999	Akram, Salman	257/778
*	D	US-6,489,229	12-2002	Sheridan et al.	438/614
*	E	US-6,130,141	10-2000	Degani et al.	438/455
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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